

**Notice of References Cited**

Application/Control No.

09/475,135

Applicant(s)/Patent Under

Reexamination

KWEON ET AL.

Examiner

BRIAN P. YENKE

Art Unit

2614

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,141,003	10-2000	Chor et al.	345/719
	C	US-			
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	F	US-			
	G	US-			
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	K	US-			
	L	US-			
	M	US-			

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	N	JP-63195727	08-1988	JAPAN	Yamaguchi	
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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